

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/797,298	ELKOVITCH, MARK D.	
Examiner		Art Unit		Page 1 of 1
Jaison P. Thomas		1751		

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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Applied Nanotech Inc. webpage (http://www.applied-nanotech.com/cntproperties.htm)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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